

# Forensic Applications for Micro-XRF



Bruker Nano Analytics, Berlin, Germany  
Webinar, September 20, 2017

Na	Mg		
K	Ca	Sc	Ti
Rb	Sr	Y	Zr
Cs	Ba	La	Hf
Fr	Ra	Ac	

V	Cr	Mn	Fe	Co	Ni	Cu	Zn	Ga	Ge	As	Se	Br	Kr
Nb	Mo	Tc	Ru	Rh	Pd	Ag	Cd	In	Sn	Sb	Te	I	Xe
Ta	W	Re	Os	Ir	Pt	Au	Hg	Tl	Pb	Bi	Po	At	Rn

Ce	Pr	Nd	Pm	Sm	Eu	Gd	Tb	Dy	Ho	Er	Tm	Yb	Lu
Th	Pa	U	Np	Pu	Am	Cm	Bk	Cf	Es	Fm	Md	No	Lr



Results		Primary energy	0.0 keV			
		Tilt angle	0.0°			
	Series	Net	[wt.%]	[wt.%]	Atom C. Error	
			[wt.%]	[at.%]	[at.%]	
Iron	K series	214751713	94.59	93.62	93.76	3.64
Nickel	K series	6274049	5.76	5.71	5.43	0.03
Copper	K series	7388	0.01	0.01	0.01	0.00
Zinc	K series	2017	0.00	0.00	0.00	0.00
Phosphorus	K series	89042	0.36	0.35	0.64	0.00
Sulfur	K series	37785	0.08	0.08	0.24	0.00
Chromium	K series	99229	0.03	0.03	0.03	0.00
Total		100.82	100.00	100.00		

XFlash®  
Technology

Micro-XRF

# M4 TORNADO Webinar Outline



- Introduction
  - Presenters
  - The M4 instrument
  - Micro-XRF
  - Information depth
- Gun Shot Residue (GSR)
  - Qualitative GSR
  - Semi quantitative GSR
- Glass fragments
  - Qualitative differentiation of glass fragments
  - Quantitative analysis
  - Semi-quantitative, as per ASTM E2926 ("finger printing")
- Live part – data extraction and evaluation
- Summary

# M4 TORNADO Webinar

## Presenters



Dr. Max J.L. Bügler

Applications Specialist,  
Bruker Nano Analytics, Berlin, Germany



Dr. Roald Tagle

Sr. Application Scientist,  
Bruker Nano Analytics, Berlin, Germany

# M4 Tornado micro-XRF spectrometer

## Standard configuration



**30 W micro-focus Rh tube with polycapillary lens**  
for excitation spot sizes  $< 20 \mu\text{m}$  (for Mo-K $\alpha$ )  
Option: other target materials and second X-ray tube  
(collimated) for extended excitation conditions

**30 mm<sup>2</sup> silicon drift detector (SDD)**  
with energy resolution  $< 145 \text{ eV}$  (for Mn-K $\alpha$ )  
Option: second detector with second independent SPU  
for double pulse throughput  
Option: 60 mm<sup>2</sup> detector(s)

**Sealed sample chamber**  
with adjustable pressure between 1 mbar (for detecting light elements down to Na) and ambient pressure

Sample stage with measurable area of 190 mm x 160 mm

Maximum sample height 120 mm, maximum sample weight 5 kg

Sample stage speed up to 100 mm/s, minimum step size 4  $\mu\text{m}$

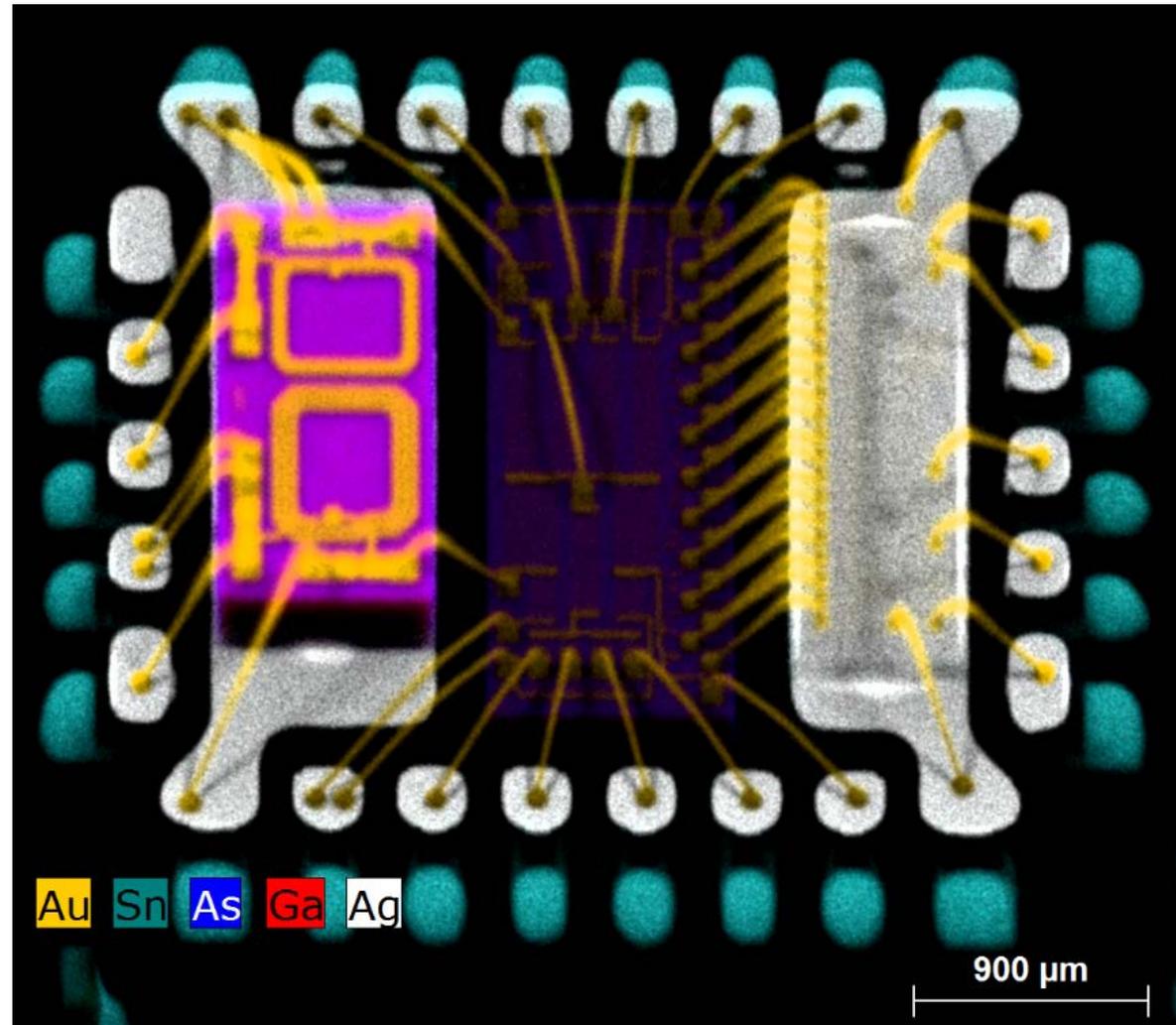
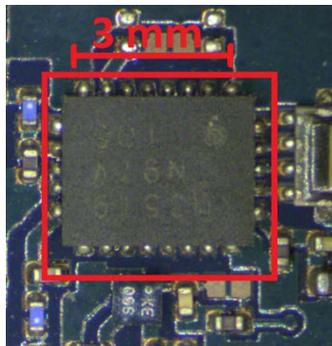


# Micro-XRF features and benefits

## At a glance

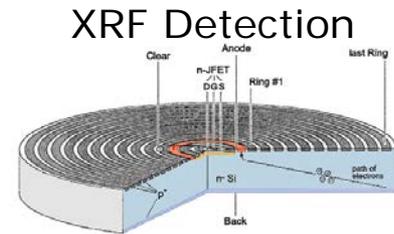
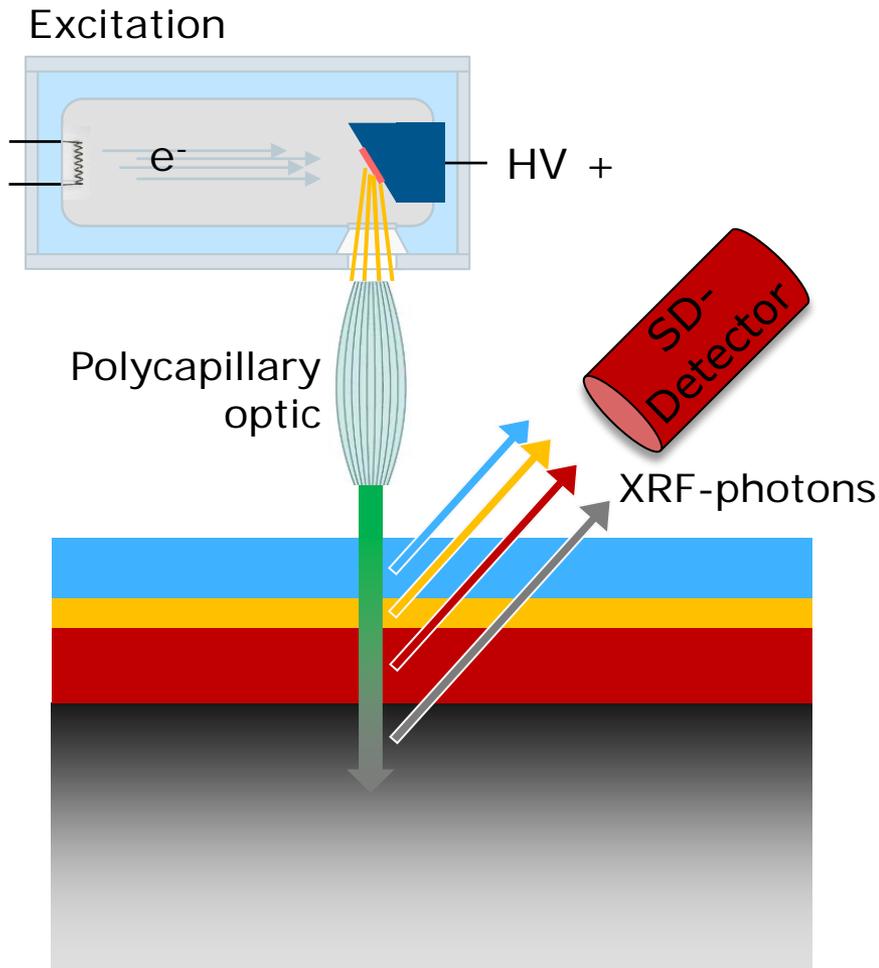


- Little to no sample preparation
- Non-destructive
- Elemental information
- Small spot analysis
- Information from within the sample
- Large-scale
- Quantification



# X-Ray Fluorescence

...information from beneath

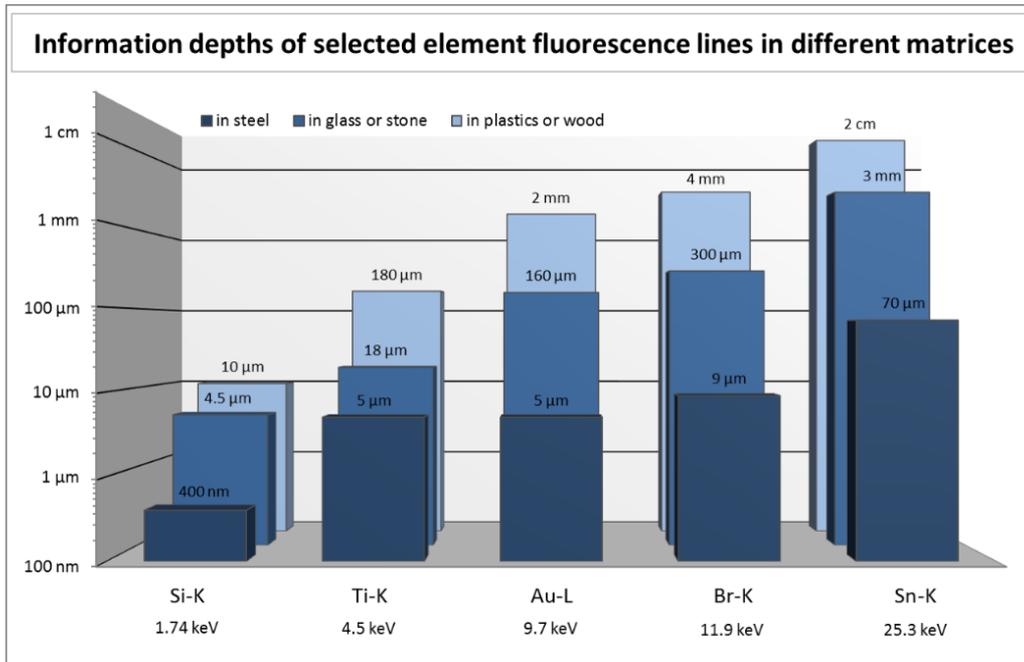


**Silicon Drift Detector**  
with XFlash<sup>®</sup> Technology

- X-rays can penetrate and excite matter
- Signal from base material and covered layers can still be detected
- X-rays are attenuated in characteristic ways on their path through matter
- Intensity ratios of observed elemental lines

# X-Ray Fluorescence

## ...understanding information depth



- Information depth depends on the energy of the photon and the density of the material
- Information on different elements can originate from different sample positions

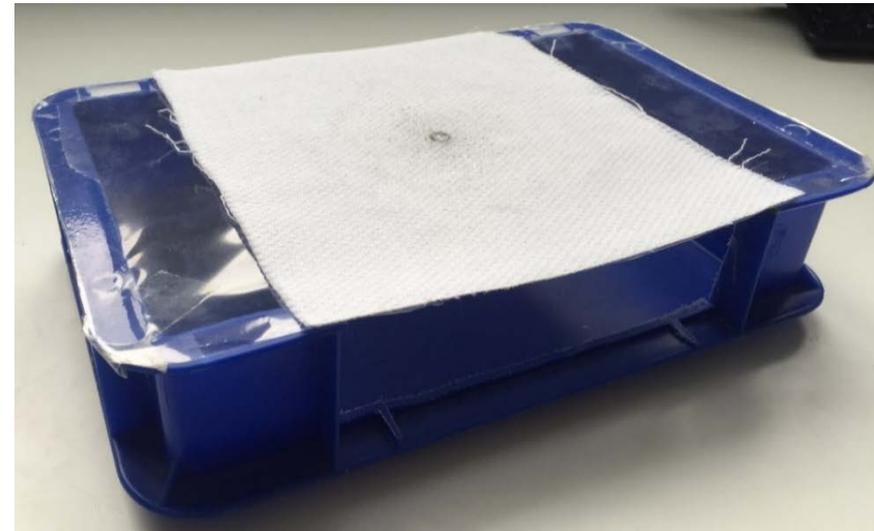
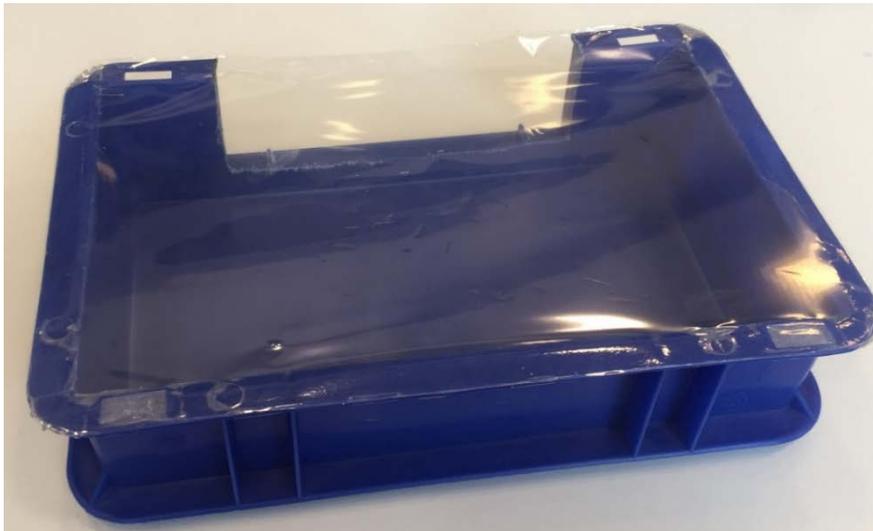


# Optimizing Results

## Sample Mounting for Minimal Background



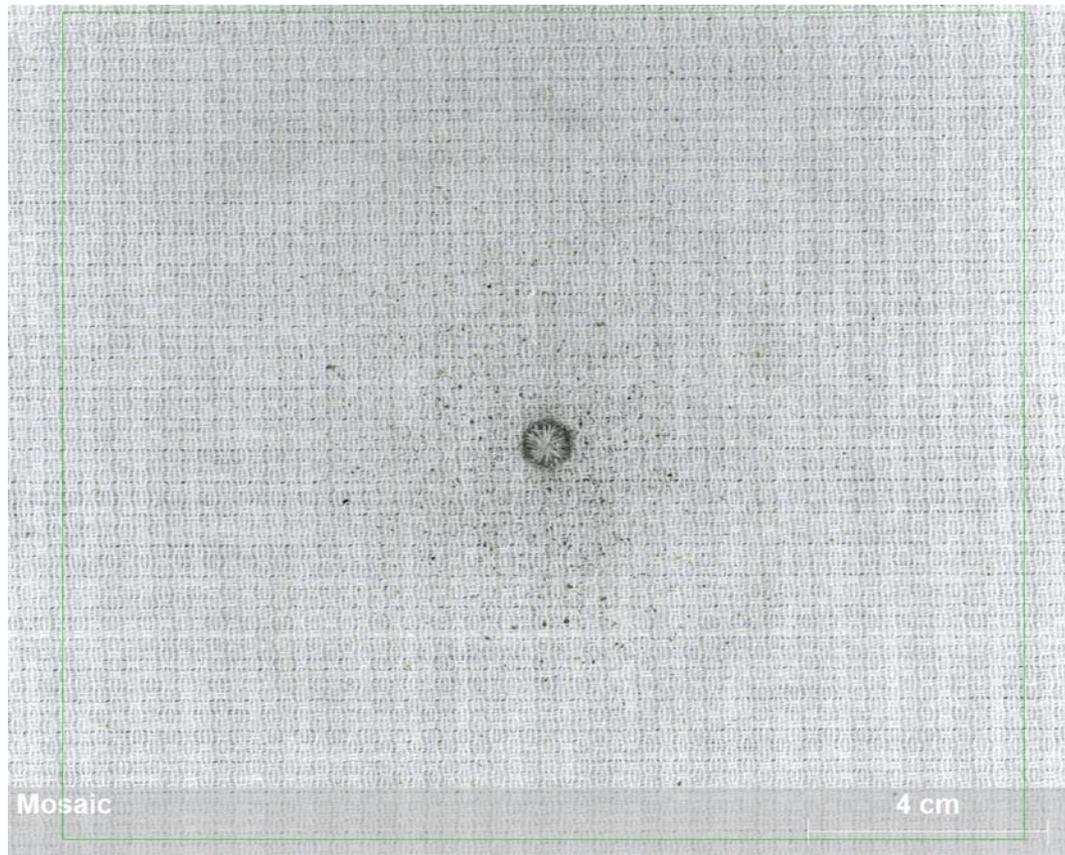
- Small signals are easily overwhelmed by background due to scattering of primary radiation (excitation), reducing the signal-to-noise ratio (SNR)
- For optimal limit of detection (LOD) background should be minimal
- Sample suspended on Mylar foil to minimize the scattering background
- Mylar can be spanned over a storage box, rear wall cut out to avoid changes in scattering at the rear edge of sample support



# Gun Shot Residue Overview Scan Settings



Overview scan of 16 cm x 14 cm with 150  $\mu\text{m}$  pixel size in 1:40 h



Optical overview image based on stitched tiles

Map information

**Mapping parameters**

Width:	1067 pixel
	160 mm
Height:	933 pixel
	140 mm
Pixel Size:	150 $\mu\text{m}$
Total number of pixel:	995511 pixel

**Acquisition parameters**

Frame count:	1/1
Pixel time:	5 ms/pixel
Measure time:	1:19 h
Overall time:	1:39 h
Stage speed:	30,0 mm/s

**Tube parameter**

High voltage:	50 kV
Anode current:	600 $\mu\text{A}$
Filter:	Empty
Optic:	Lens
SpotSize:	14
Chamber at:	Vacuum 20,1 mbar
Anode:	Rh

**Detector parameters**

Selected detectors:	1,2
Max. pulse throughput:	130000 cps

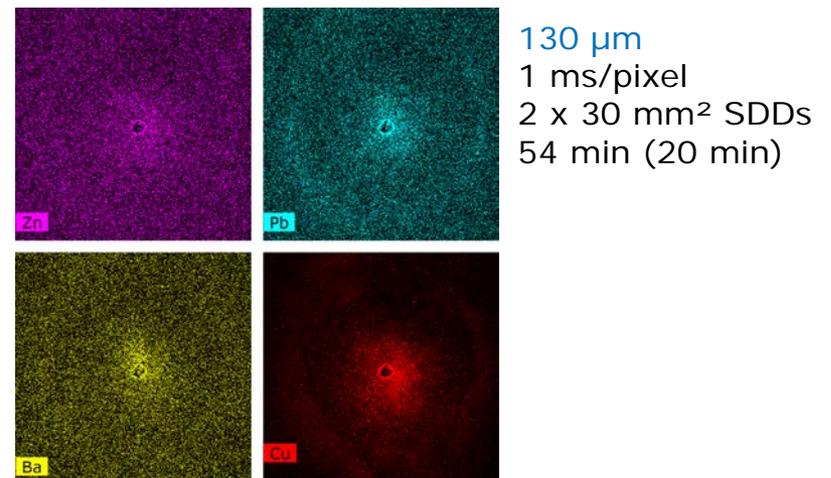
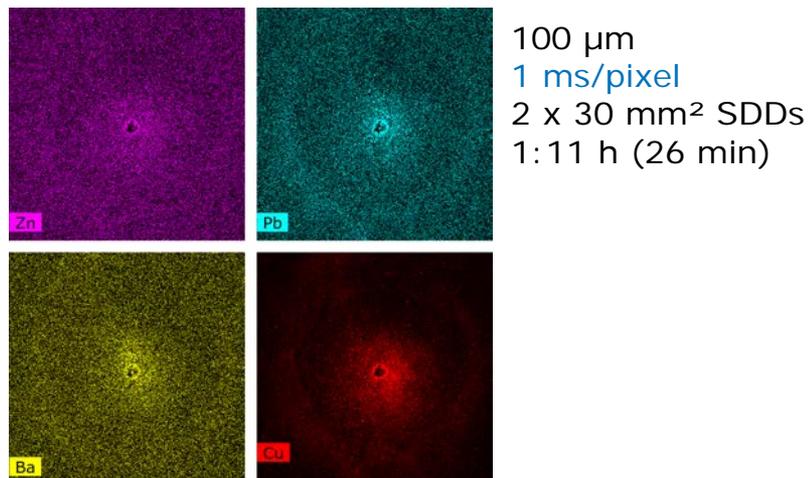
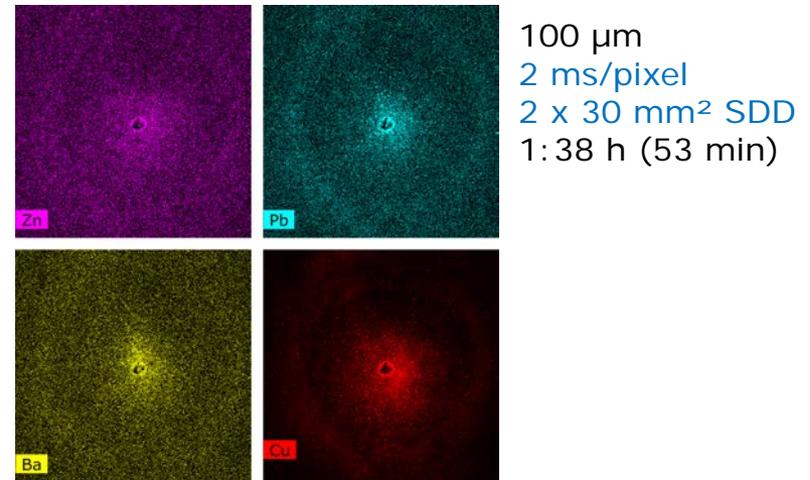
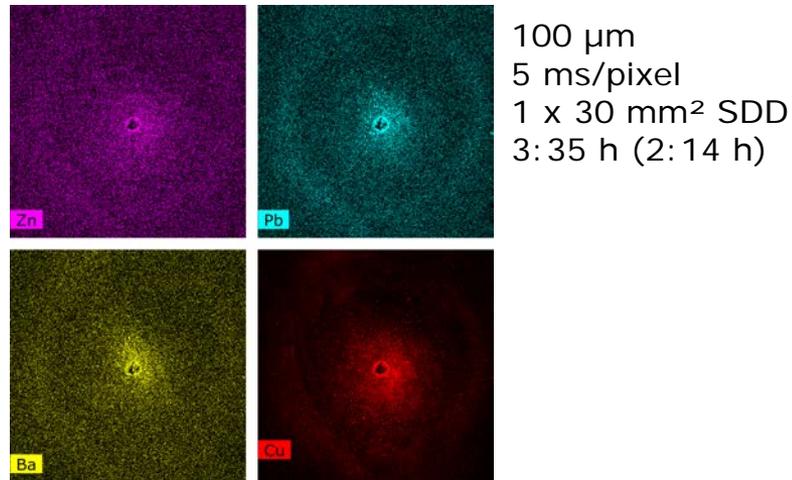
Close

# Gun Shot Residue

## Comparison of measurement settings



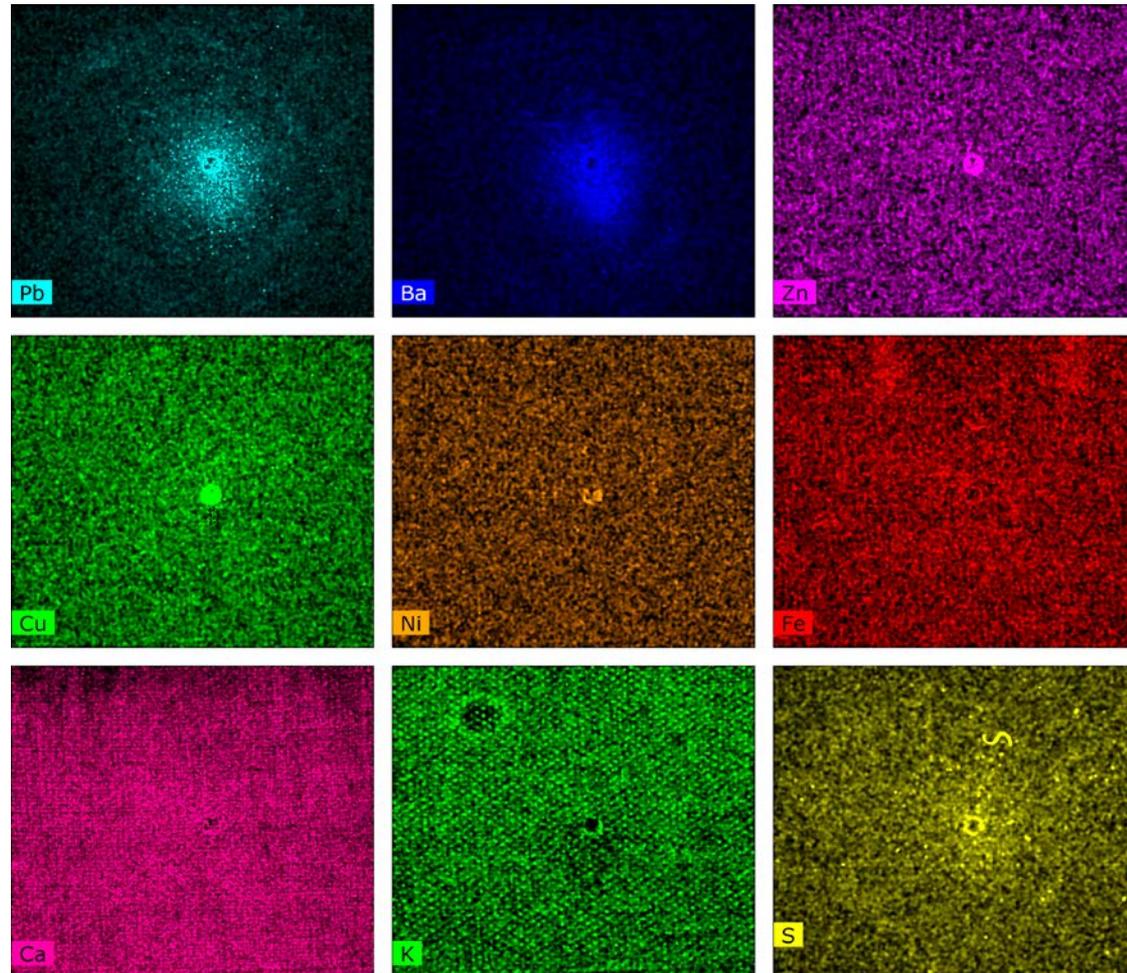
Scanned area: 13 cm x 13 cm, 20 mbar chamber pressure, 50 kV / 600  $\mu$ A



# Gun Shot Residue Element Distribution Maps



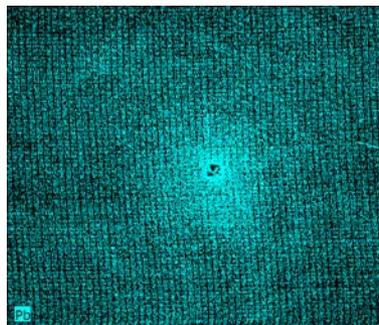
- Distribution maps for each element can be extracted easily
- Distribution of different elements allow for analysis of different aspects
- Pb, Ba, and S show cloud-like area around bullet hole
- K shows some contamination of the sample in top left part of specimen



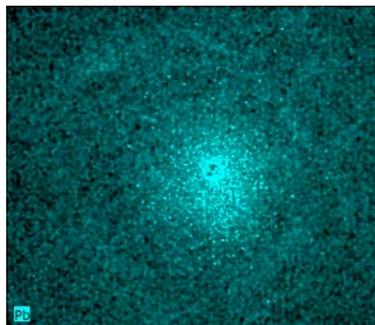
# Gun Shot Residue Element Distribution Maps



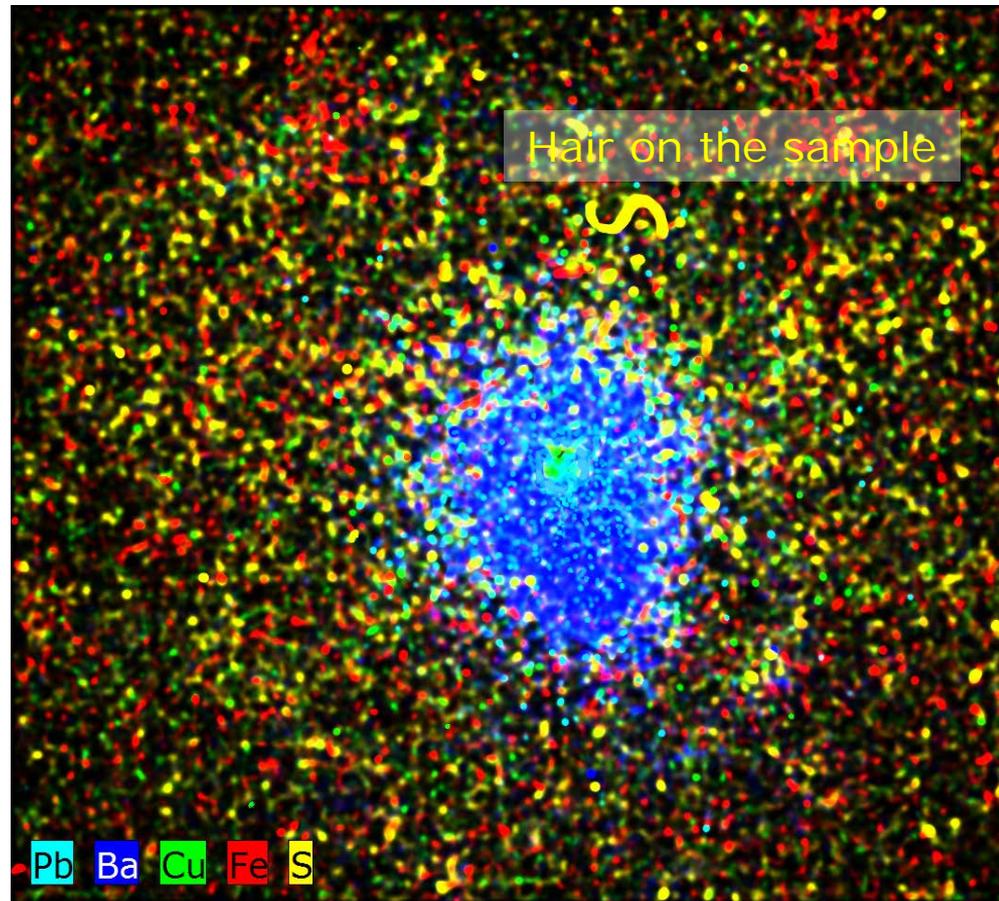
- Selection of fewer elements in a single plot allows for coordination of different signals
- Adjustment of threshold for intensity to display allows to suppress artefacts from scattering
- Fast deconvolution (FD) allows for efficient extraction of useful signal from background



without FD

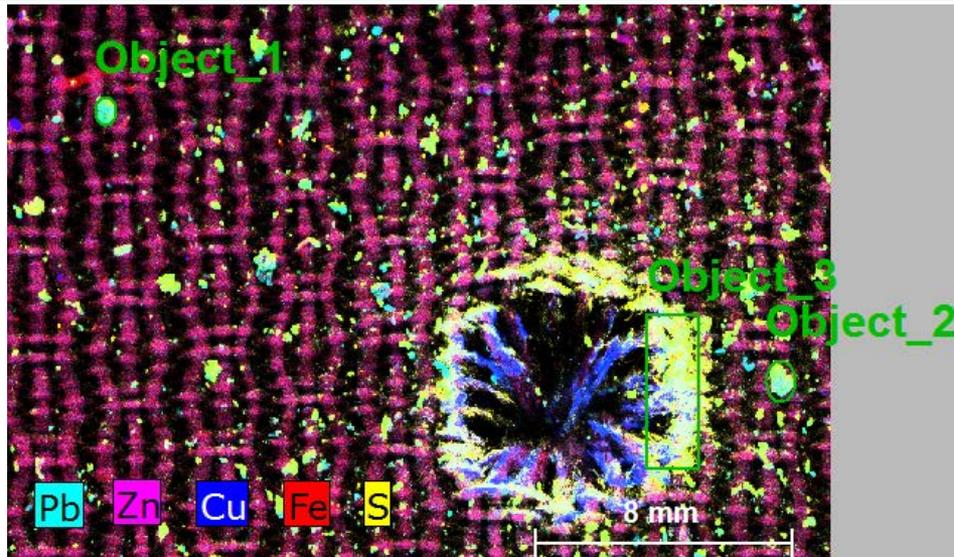


with FD

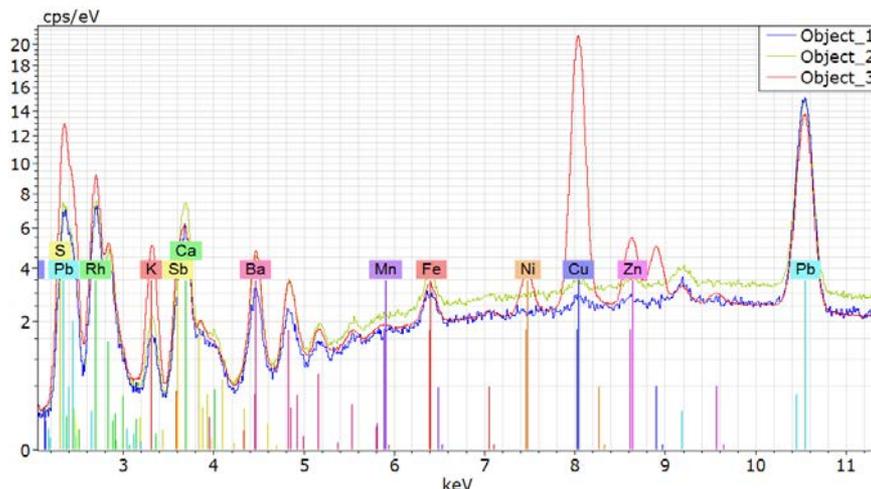


# Gun Shot Residue

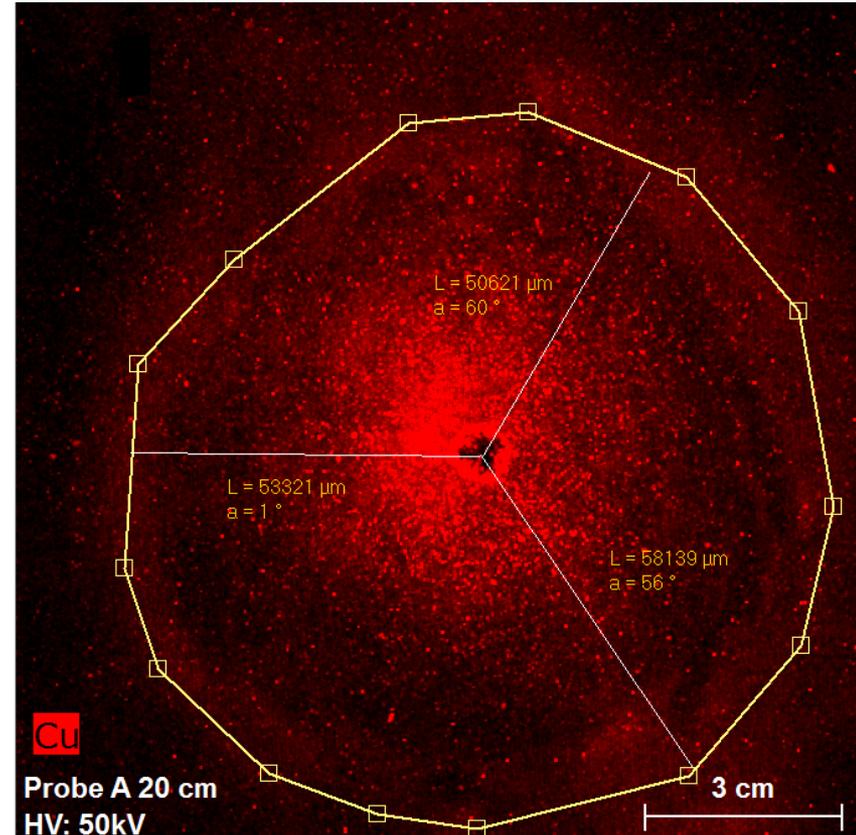
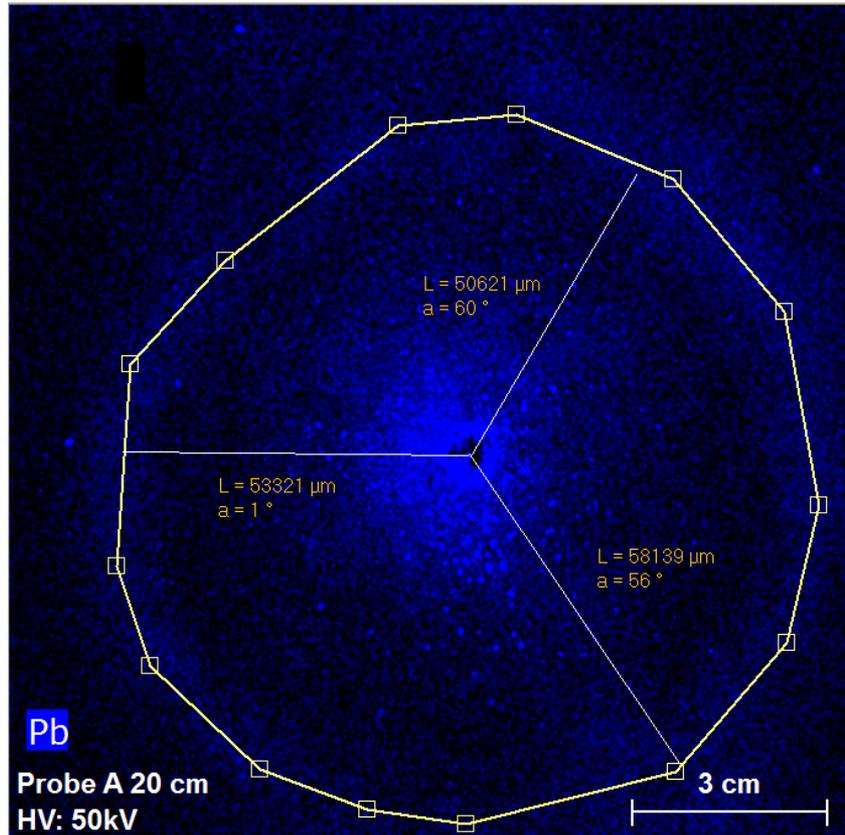
## Details on Features



- By analyzing objects in the map, element composition can be qualitatively compared
- At the bullet hole K, Ni, Cu, and Zn are found as well as increased levels of Pb and Ba
- The sprinkles around only show Pb, S, and Ba



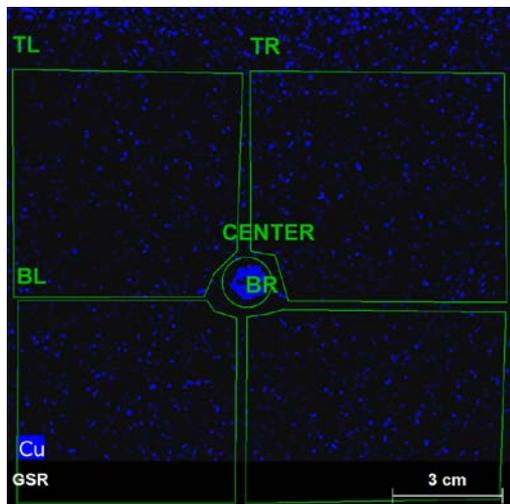
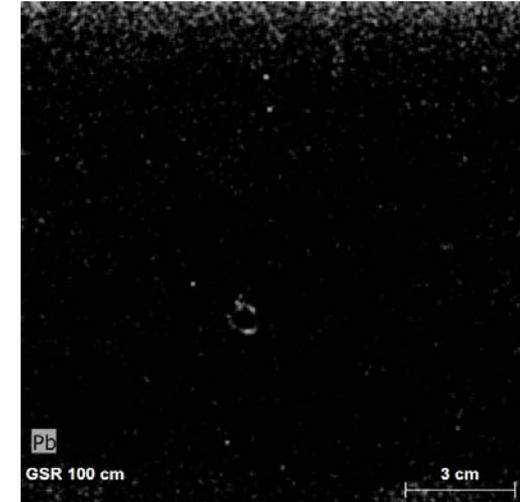
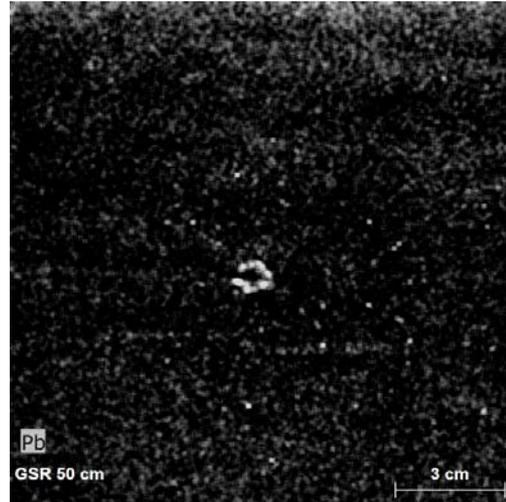
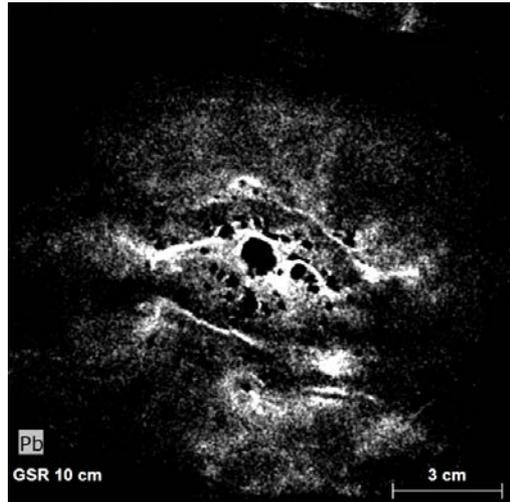
# Geometrical Analysis On 20 cm Sample on Cloth



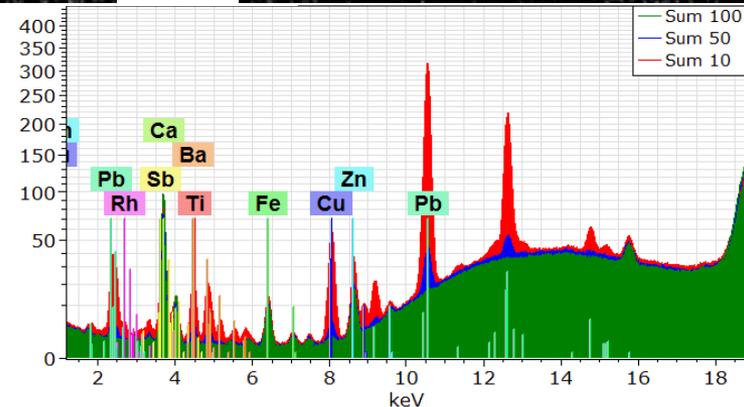
- Cloth appears to hold smoke residue and particles significantly better than paper
- Allows for analysis of significantly larger areas (due to better SNR)

# Large Variation of Distance

## Comparison 10, 50 and 100 cm on cloth



- Sum spectra over different samples (same size)
- With increasing distance the found amount of GSR decreases



	Ca	Ti	Fe	Cu	Zn	Rh	Sb	Ba	Pb	Sum
Sum 100	118411	2039	14004	1185	25710	57634	0	0	7874	<b>226857.00</b>
Sum 50	90313	2646	14529	5735	28024	61947	0	4143	86358	<b>293695.00</b>
Sum 10	101013	9347	20055	92851	53984	77105	157	59722	927696	<b>1341930.00</b>

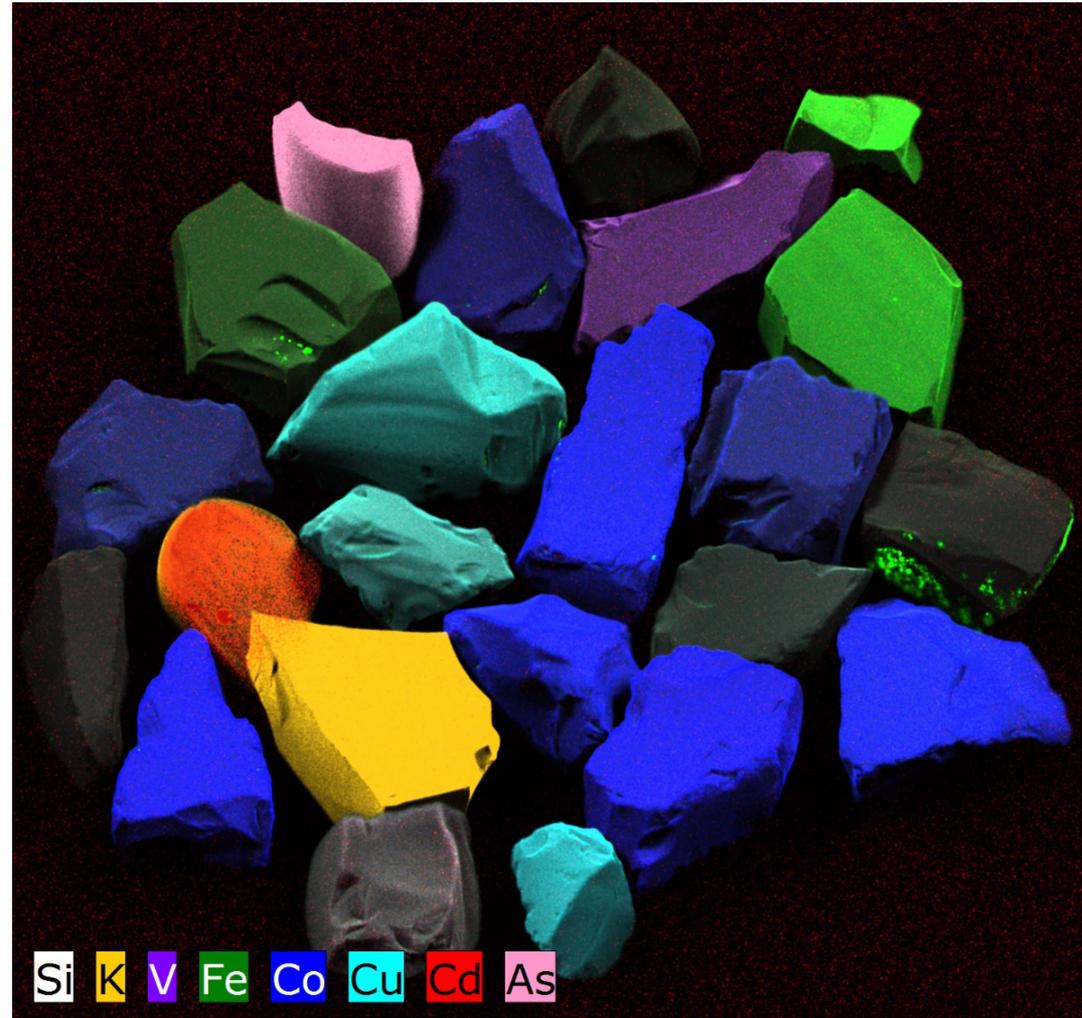
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# Glass Analysis

## Qualitative: Color Mixing



- At-a-glance classification by mixing the colors which represent selected marker elements
- Contaminations and float face can be easily be identified

# Glass Analysis

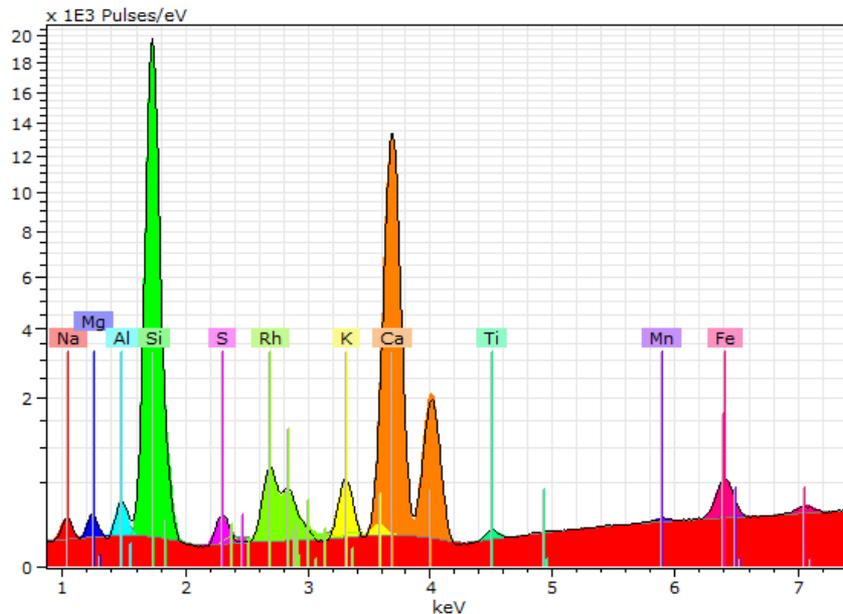
## Quantitative, using FP



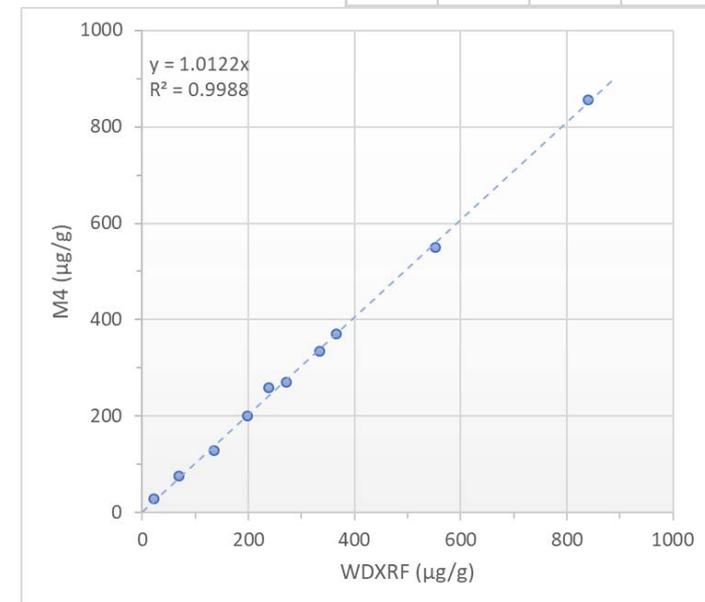
Powerful FP algorithm based on forward calculation of spectra

The quantitative results were shown to be very much in line with WDXRF measurements for steels (LR 465, Webinar from 25.08.2016) and glasses (here results from Stazione Sperimentale del Vetro, Murano)

Sample	Pb concentration ( $\mu\text{g/g}$ )		
	WDXRF	M4	$\Delta$
A	22	29	-7
B	69	77	-8
C	135	128	7
D	198	200	-2
E	239	260	-21
F	271	271	0
G	335	334	1
H	365	371	-6
I	552	550	2
L	841	855	-14



Forward calculation of glass (NIST 620) spectrum



Data courtesy of Roberto Falcone, SSV

# Glass Analysis

## Semi-quantitative, as per ASTM E2926



ASTM E2926 – 13

Standard Test Method for

Forensic Comparison of Glass Using Micro X-ray Fluorescence Spectrometry

- No actual quantification of the sample required
- Based on peak intensity ratios
- Detailed and well-described workflow

1.3 This test method does not replace knowledge, skill, ability, experience, education, or training and should be used in conjunction with professional judgment.

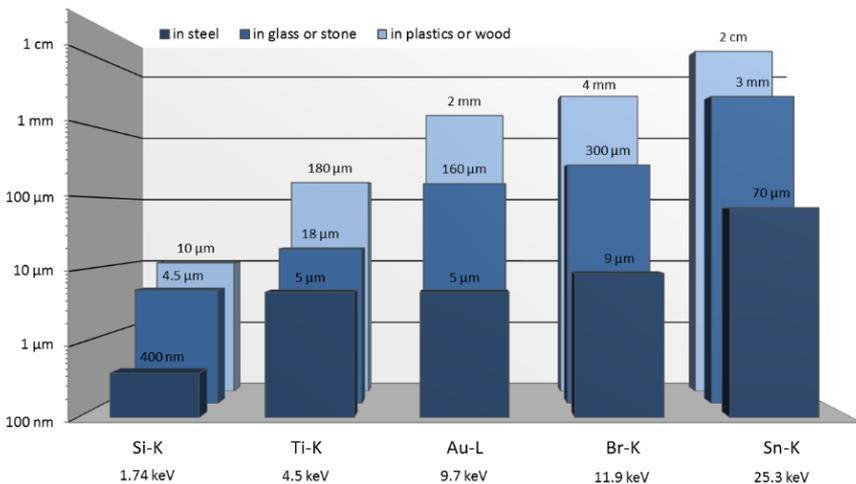
# Glass Analysis

## Restrictions due to information depth

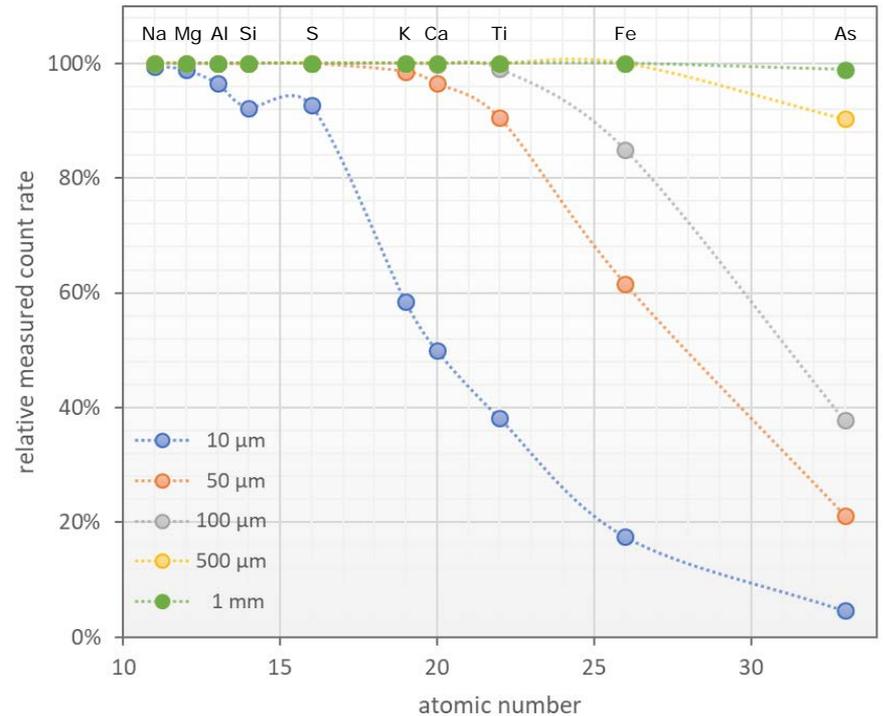


9.1.3.4 For comparisons, glass specimen should be of similar size, shape, and **thickness** to each other. For full thickness fragments of float glass, comparisons should be made between similar surface types (for example, non-float surface to non-float surface).

Information depths of selected element fluorescence lines in different matrices



NIST 620 - Soda lime flat glass  
count rates relative to infinite thickness

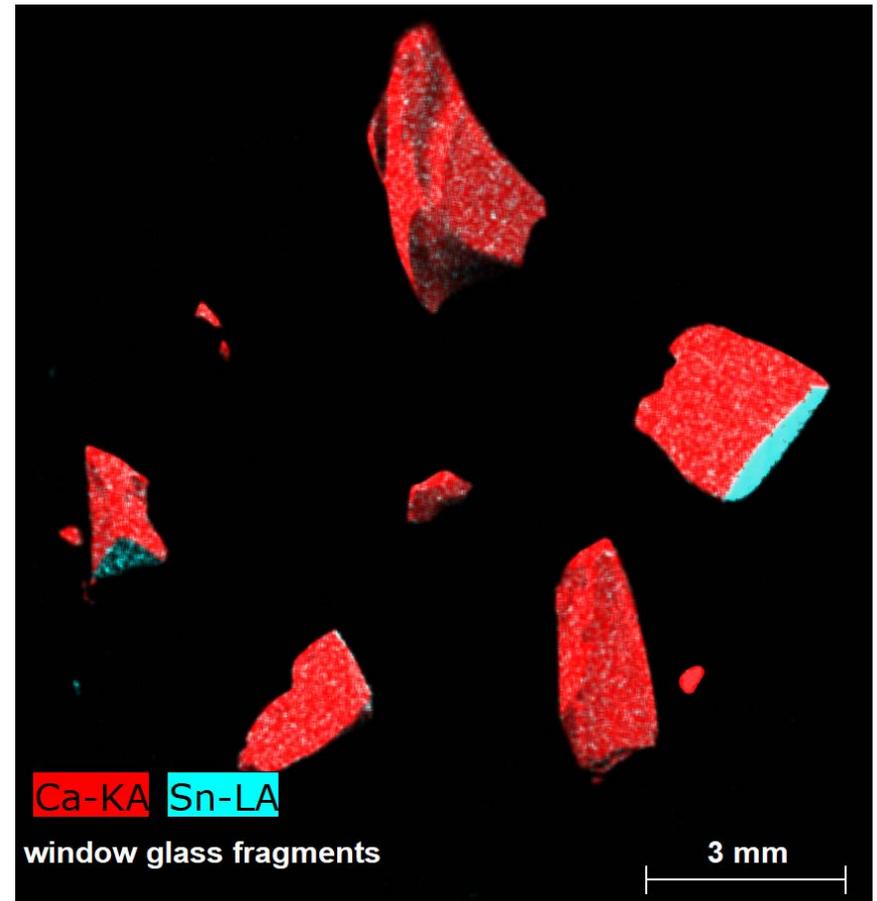
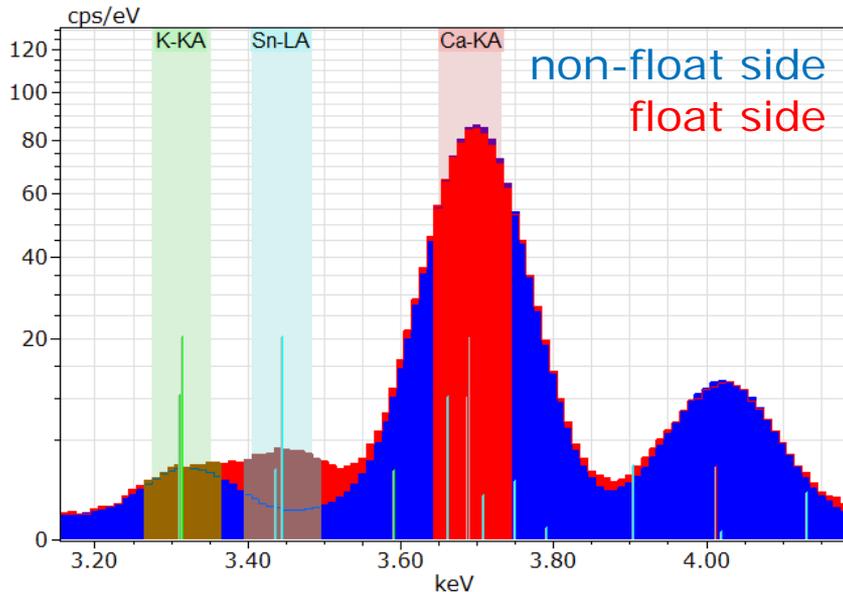


# Glass Analysis

## Identifying the non-float surface



9.1.3.4 For comparisons, glass specimen should be of similar size, shape, and thickness to each other. For full thickness fragments of float glass, comparisons should be made between similar surface types (for example, non-float surface to non-float surface).



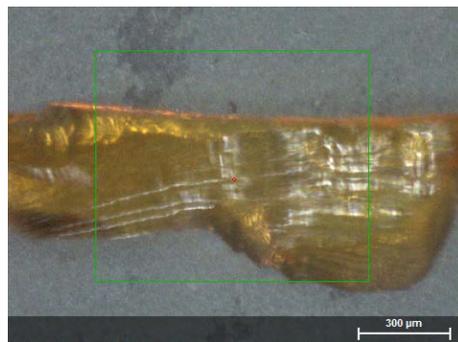
# Glass Analysis

## on the importance of accurate focusing

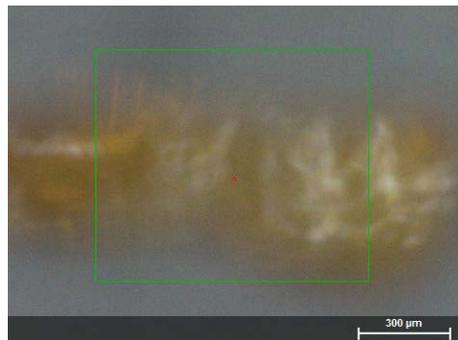


Defocusing of  $\sim 1$  mm changes relative Na intensity (at 20 mbar) by  $\sim 8.5$  ‰  
(general intensity loss/gain by change in solid angle of detection is  $\sim 10$  ‰)

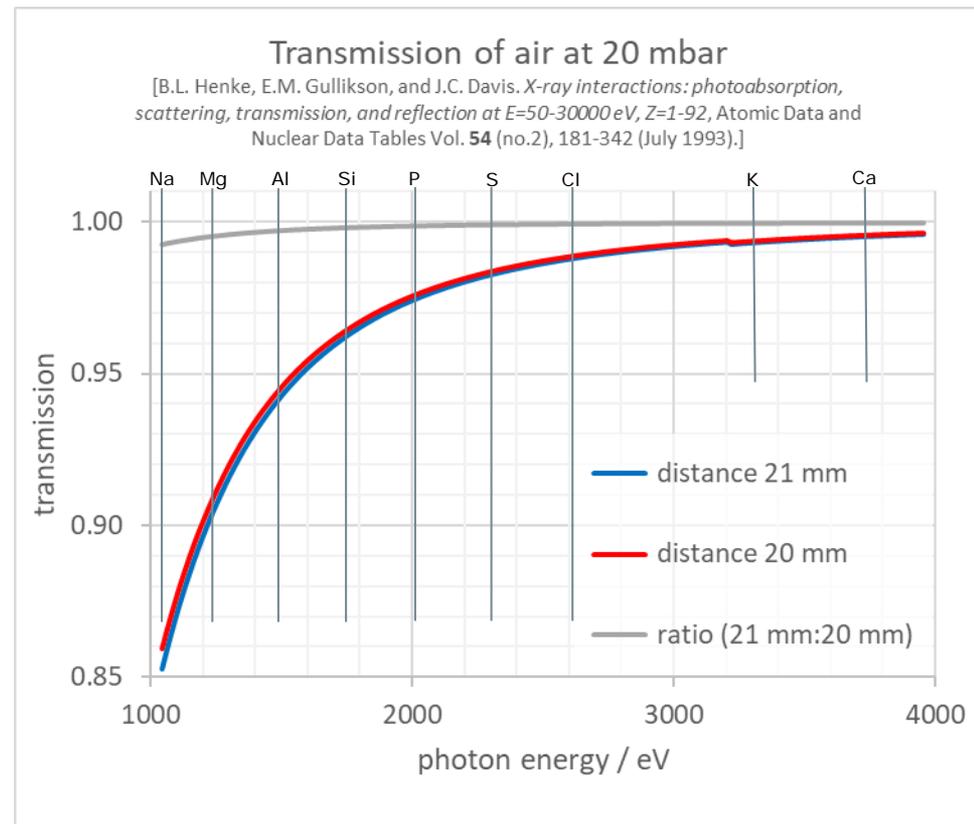
Note: At 10 mbar the difference ratio down to only 4 ‰



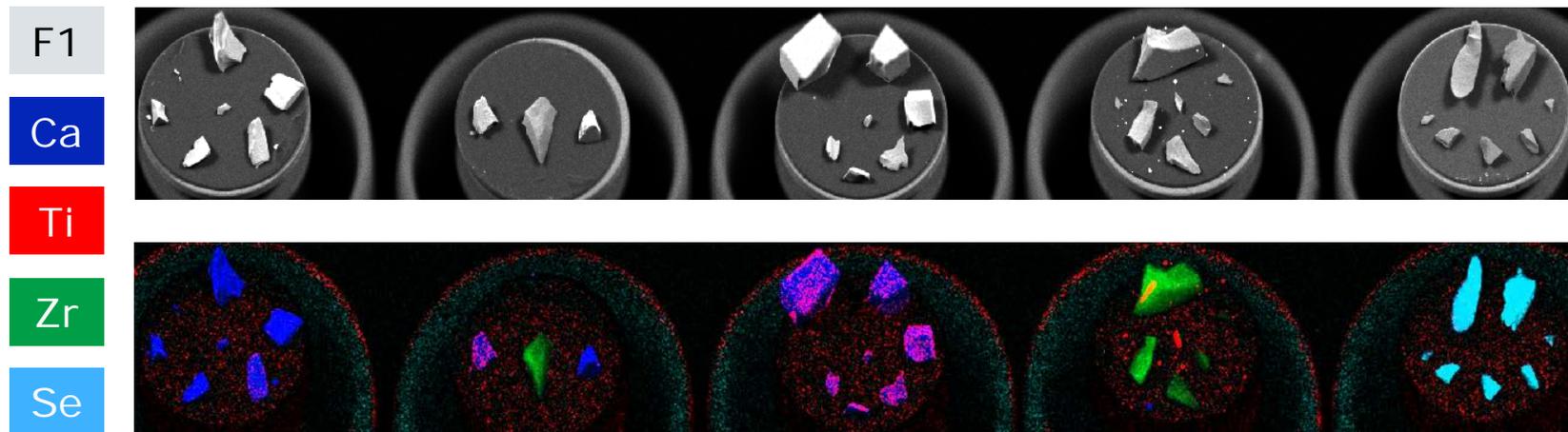
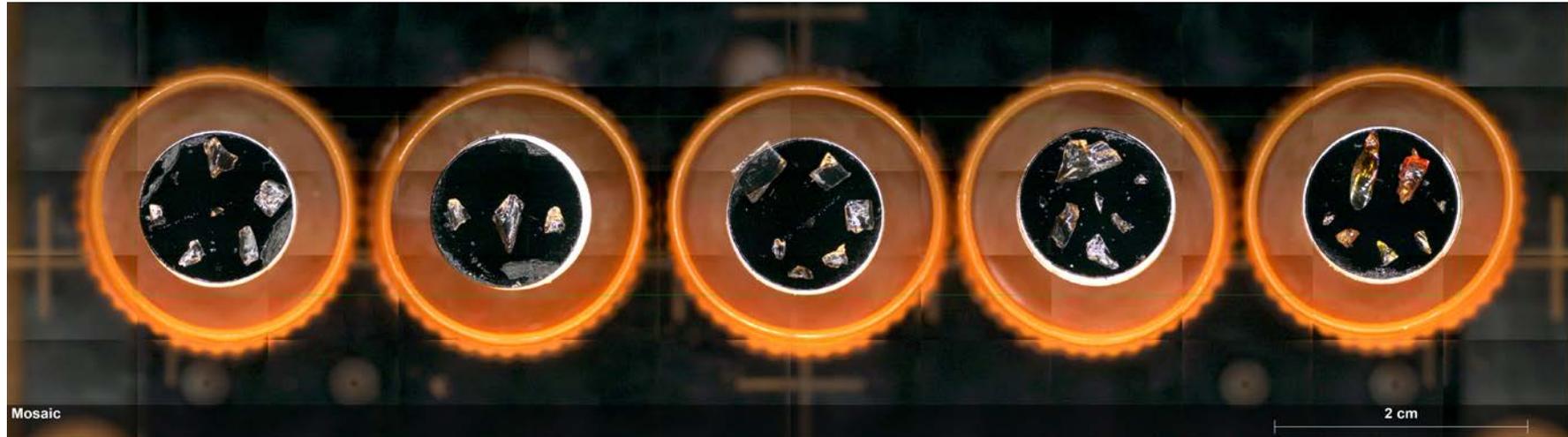
focused



defocused by 1 mm



# Glass Analysis Classification



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# Glass Analysis Live



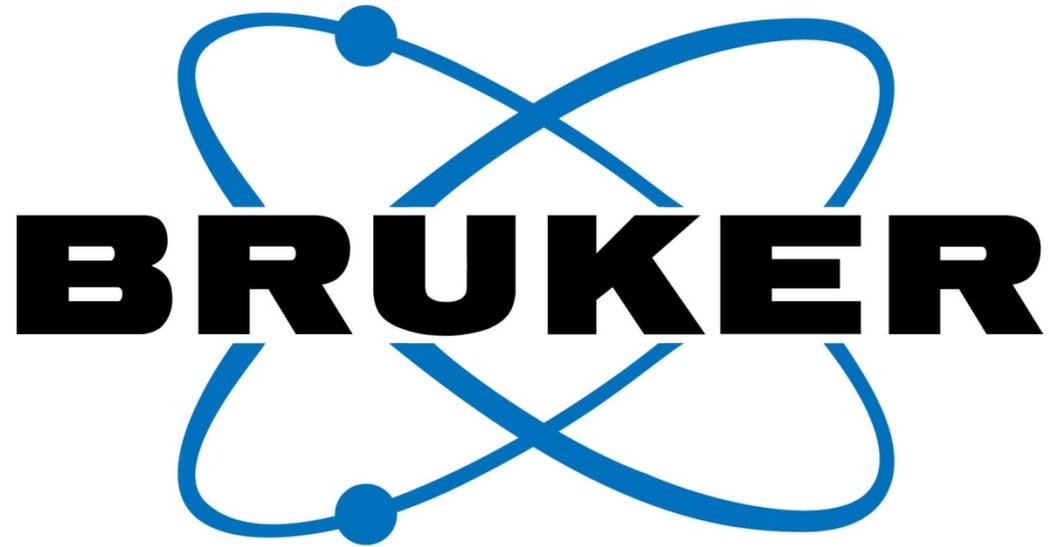
# Summary



- Micro-XRF allows for fast, spatially resolved mapping of large sample areas
- It is non-destructive and requires almost no sample preparation
- Gunshot residues on cloth are best measured with a „spacing“ between sample and stage. Thus SNR is optimized
- Multiple data mining tools allow for offline analysis
- For glass shards analysis the information depth for the different elements has to be kept in mind
- Glass shards can be analyzed in different ways:
  - Qualitative, by simply looking at the color mixture in the map
  - quantitative, as the M4's FP algorithm yields stable and reliable results
  - Semi-quantitative, based on intensity ratios, according to ASTM E2926

## Are There Any Questions?

Please type in the questions you might have  
in the Q&A box and press *Send*.



Innovation with Integrity